


<b>Search Notes</b>  	<b>Application/Control No.</b>  10576789	<b>Applicant(s)/Patent Under Reexamination</b>  HASEGAWA ET AL.
	<b>Examiner</b>  WEI ZHAO	<b>Art Unit</b>  2475

SEARCHED			
Class	Subclass	Date	Examiner
711	216	6/11/2009, 4/15/2010, 1/3/2011	KA, WZ
370	428,429,389, 395.3	6/11/2009, 4/15/2010, 1/3/2011	KA, WZ
375	240.26,240.29,240.23	6/11/2009	KA

SEARCH NOTES		
Search Notes	Date	Examiner
East Text Search (US-PGPUB;USPAT;DERWENT;IBM_TDB)	6/4/2009, 4/15/2010, 1/3/2011	KA, WZ
Double Patenting Search; Inventor and Assingee Search	6/11/2009, 4/15/2010, 1/3/2011	KA, WZ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
370	390	4/15/2010	WZ

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